

FTIR study of CO adsorption and electrical characterization of novel Pt/TiO₂ Nanowire Catalysts fabricated using Electron Beam Lithography.

P. Deshlahra and E. E. Wolf*

Department of Chemical and Biomolecular Engineering, University of Notre Dame,
Notre Dame, Indiana 46556 (USA)

*ewolf@nd.edu

Introduction

Model supported catalysts on flat surfaces form an important link between single crystal surfaces and real world supported catalysts. The use of nanofabrication techniques to prepare such model catalysts has received a lot of attention in recent years [1]. In the present study Pt/TiO₂ catalysts have been fabricated using e-beam lithography (EBL) and used to characterize the electrical properties of metal-support junction.

Materials and Methods

TiO₂ films were prepared by electron beam evaporation of titanium metal on a silicon wafer followed by thermal oxidation in air. Platinum nanowires were prepared by electron beam lithography. Zep-520A e-beam resist was spun on the substrate, followed by e-beam exposure using JEOL 9300 tool, development, platinum metal deposition and liftoff (at Center for Nanoscale Materials, Argonne National Laboratories). The e-beam exposed pattern was developed using a novel cold development process [2] which helped improve the resolution. This allowed e-beam writing at a high beam current of 1nA. 25nm nanowires with 200nm spacing covering a 4mmx4mm area were fabricated using an exposure time of less than two hours. For electrical characterization of the fabricated samples, bottom and top gold pads connected to TiO₂ support and Pt nanowires respectively were also fabricated. These nanofabricated samples were characterized using SEM and AFM imaging. Current-voltage (I-V) measurements were performed on the samples after oxidation-reduction treatments at several temperatures. CO chemisorption on the fabricated Pt nanowires was studied using specular reflection FTIR spectroscopy. Novel Pt(nanowires)/TiO₂/Au structures with optimized TiO₂ thickness were fabricated which allowed significant enhancement of FTIR signal and thus improved the detection limits.

Results and Discussion

SEM and AFM studies show that the

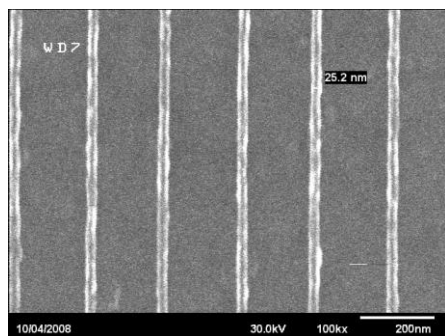


Figure 1. SEM image of the Pt nanowires supported on TiO₂ substrate fabricated using electron beam lithography.

fabricated nanowires were about 25nm wide and 8nm high. The continuity and uniformity of nanowires over a large area was good. The fabrication method described above was faster than other EBL based catalysts fabrication reported in the literature and thus improves the throughput to some extent. Figure 1 shows the SEM image of one sample. The rectifying behavior seen in the I-V curve for a Pt nanowire – TiO₂ junction was found to be different from a Pt film – TiO₂ junction (figure 2) due to effect of increased interfaces and boundary sites.

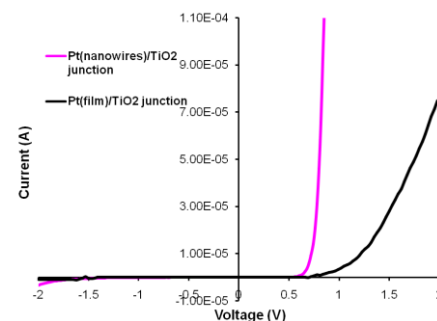


Figure 2. Comparison between the current-voltage (I-V) behaviors of Pt nanowire/TiO₂ junction and a Pt film/TiO₂ junction.

the electrical properties of the junction. Further, the effect of in-situ biasing of the nanowire-support junction, using an external potential, on CO adsorption peaks and catalytic activity of the nanofabricated catalysts will also be investigated. Ab-initio studies have been performed to investigate CO adsorption on Pt(111) surface and indicate a significant effect of electric fields resulting from an external potential on C-O normal mode vibrational frequencies.

Significance

This work demonstrates the ability to use nanofabrication techniques to directly characterize the properties of metal-support nano-junctions using electrical measurements. This will help understand the electronic effects attributed to metal-support boundary and extent to which it plays a role in catalysis. It is an additional advantage of lithographic techniques along with the ability to fabricate structures with well defined shape, size and composition.

Acknowledgement

Support of this work by NSF grant 0730190 is gratefully acknowledged.

References

1. Yan X. M., Kwon S., Contreras A. M., Koebel M. M., Bokor J. and Somorjai G. A., *Catal. Lett.* 105 (3-4), 127-132 (2005).
2. Ocola L. E. and Stein A., *J. Vac. Sci. Tech. B.* 24 (6), 3061-3065 (2006).
3. Jochum W., Eder D., Kaltenhauser G. and Kramer R., *Top. Catal.* 46(1-2), 49-55 (2007).